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Application/Control No.	Applicant(s)/Patent un Reexamination	nder
10/765,911	CAMPBELL ET AL.	
Examiner	Art Unit	
Thinh T. Nguyen	2818	

SEARCHED							
Class	Subclass	Date	Examiner				
257	100	10/23/2005	TTN				
257	103	10/23/2005	TTN				
257	42	10/24/2005	TTN				
257	E21.029	10/24/2005	TTN				
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INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				
257	loo	11/16/05	TTW				
US	PUB	11/16/0	TOY				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)						
	DATE	EXMR				
east	10/23/2005	TTN				
EAST	10/24/2005	TTN				
EAST	11/16/05	TIN				